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NIP-261

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

Y. TAKEZAWA et al

Serial No.

Filed: February 26, 2002

For: METHOD AND APPARATUS OF DIAGNOSING

DETERIORATION OF AN ARTICLE

INFORMATION DISCLOSURE STATEMENT (IDS) UNDER § 1.97 AND § 1.98

Commissioner for Patents Washington, D.C. 20231

Sir:

- 1. This IDS should be considered:
- (a) when filed within three months of the filing date of the present application, or within three months of the filing date of the National Stage as set forth in § 1.491 in an international application, or before the mailing date of a first Office Action on the merits, whichever occurs last;
- (b) when filed before the mailing date of either a Final Rejection under § 1.113 or a Notice of Allowance under § 1.311, whichever occurs first and when 1(a) does not apply. For this purpose, there is included herein either a certification in section 4 below (included when indicated by a marked box), or a fee of \$180.00 (a check in the amount of \$180.00 is enclosed, or if not see section 5 below);
- (c) when filed prior to the payment of the Issue Fee, when 1(a)-(b) do not apply, and when a certification is included in section 4 below (included when indicated by a marked box); then the Applicant(s) hereby petition(s) and request(s) consideration of this IDS, and provided herewith is a fee of \$180.00 (a check in the amount of \$180.00 to cover the petition fee, or if not see section 5 below).



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- 2. When 1(a)-(c) do not apply, then it is requested that this IDS be placed in the file.
- 3. Listing of the information submitted is on the attached Form PTO-1449, which forms a part of this IDS. A copy of each listed document is enclosed.
- 4. If a fee or additional fee is required, the Commissioner is hereby authorized to charge any fee or additional fee that may be required and credit any excess to Deposit Account No. 50-1417.
- 5. No explanation of relevancy is being provided for the documents because each is either in the English language or discussed in the present Specification.
- 6. If the PTO determines that part(s) of the required content is inadvertently omitted, then it is requested that the Applicant(s) be given additional time and specific identification of such omission(s) to enable full compliance.

Respectfully submitted,

John R. Matting/y Registration No. 30,293

Attorney for Applicants

MATTINGLY, STANGER & MALUR 1800 Diagonal Rd., Suite 370 Alexandria, Virginia 22314 (703) 684-1120

Date: February 26, 2002

FORM PTO-1449 (REV. 7-80)					MENT OF COMMERC TRADEMARK OFFIC		SE	SERIAL NO.				
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)					APPLICANT Y. TAKEZAWA et al							
						FILING DATE February 26, 2002	GF	GROUP				
					U.S. PATEN	T DOCUMENTS						
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	AL	11-330185		11/30/99	Japan (w/ Eng	lish Abstract)			·			
	АМ	2000- 131243		05/12/00	Japan (w/ Eng	lish Abstract)						
	AN	11-235097		08/27/99	Japan (w/ Eng	lish Abstract)						
	AO	9-222393		08/26/97	Japan (w/ Eng	lish Abstract)						
	AP	10-	115601	05/06/98	Japan (w/ Eng	lish Abstract)						
				OTHER DOCU	MENTS (Including A	uthor, Title, Date, Pertinent I	Pages, etc	c.)				
	AR	T. Ikeda et al, "Development of the Ultrasonic Degradation Tester for Low Voltage Cables", TRANSACTIONS OF THE INSTITUTE OF ELECTRICAL ENGINEERS										
		OF JAPAN, Vol. 120-B, No. 11, pp. 1437-1442, 2000.										
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	AL	11-118773		04/30/99	Japan (w/ Engl	ish Abstract)						
	АМ	10-19856		01/23/98	Japan (w/ Engl	ish Abstract)						
	AN	7-35732		02/07/95	Japan (w/ Engl	ish Abstract)		····-				
	АО	7-245869		09/19/95	Japan (w/ Engl	ish Abstract)						
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